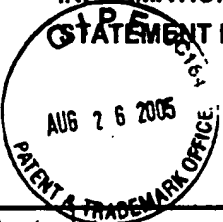


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		Filing Date		August 26, 2003	
		First Named Inventor		Gregory R. Hanson et al.	
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		Examiner Name		Connolly, Patrick J	
Sheet	1	of	2	Attorney Docket Number	UBAT1520
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Examiner Signature	PATRICK CONNOLLY			Date Considered	09.21.2005

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